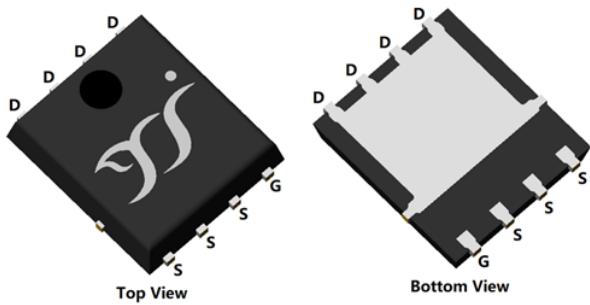
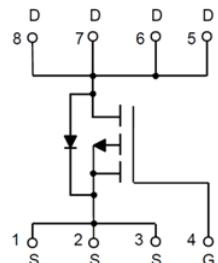




P-Channel Enhancement Mode Field Effect Transistor



PDFN5060-8L



Product Summary

• V_{DS}	-60V
• I_D	-74A
• $R_{DS(ON)}$ (at $V_{GS}=-10V$)	<13mΩ
• $R_{DS(ON)}$ (at $V_{GS}=-4.5V$)	<22mΩ
• 100% EAS Tested	
• 100% ∇V_{DS} Tested	
• ESD Level(HBM)	Class 3A

General Description

- Excellent package for heat dissipation
- High density cell design for low $R_{DS(ON)}$
- Moisture Sensitivity Level 1
- Epoxy Meets UL 94 V-0 Flammability Rating
- Halogen Free

Applications

- Load Switch
- Power Management

■ Limiting Values

Parameter	Conditions		Symbol	Min	Max	Unit
Drain-source Voltage			V_{DS}	-	-60	V
Gate-source Voltage			V_{GS}	-20	20	
Continuous Drain Current (Note 1,2)	Steady-State	$T_A=25^\circ C, V_{GS}=-10V$	I_D	-	-10	A
		$T_A=100^\circ C, V_{GS}=-10V$		-	-7	
Continuous Drain Current (Note 1,3)		$T_C=25^\circ C, V_{GS}=-10V$, Chip limitation		-	-74	
		$T_C=100^\circ C, V_{GS}=-10V$		-	-52	
Pulsed Drain Current	$T_C=25^\circ C, t_p \leq 10\mu s$		I_{DM}	-	-296	
Maximum Body-Diode Continuous Current	$T_C=25^\circ C$		I_S		-74	
Avalanche energy (non-repetitive)	$T_J=25^\circ C, V_G=-10V, R_G=25\Omega, L=0.5mH, I_{AS}=-30A$		EAS	-	225	mJ
Total Power Dissipation (Note 1,2)	Steady-State	$T_A=25^\circ C$	P_D	-	2.7	W
		$T_A=100^\circ C$		-	1.4	
Total Power Dissipation (Note 1,3)	Steady-State	$T_C=25^\circ C$		-	150	
		$T_C=100^\circ C$		-	75	
Junction and Storage Temperature Range			T_J, T_{STG}	-55	175	°C

■ Thermal Resistance

Parameter	Symbol	Typ	Max	Units
Thermal Resistance Junction-to-Ambient (Note 3)	$R_{\theta JA}$	-	55	°C/W
Thermal Resistance Junction-to-Case	$R_{\theta JC}$	-	1	

■ Ordering Information (Example)

PREFERRED P/N	PACKING CODE	Marking	MINIMUM PACKAGE(pcs)	INNER BOX QUANTITY(pcs)	OUTER CARTON QUANTITY(pcs)	DELIVERY MODE
YJG013P06A	F1	YJG013P06A	5000	10000	100000	13" reel



■ Electrical Characteristics

Parameter	Symbol	Conditions	Min	Typ	Max	Units
Static Parameter						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS}=0V, I_D=-250\mu A, T_j=25^\circ C$	-60	-	-	V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS}=-60V, V_{GS}=0V, T_j=25^\circ C$	-	-	-1	μA
		$V_{DS}=-60V, V_{GS}=0V, T_j=150^\circ C$	-	-	-100	
Gate-Source Leakage Current	I_{GS}	$V_{GS}=\pm 20V, V_{DS}=0V, T_j=25^\circ C$	-	-	± 100	nA
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=-250\mu A, T_j=25^\circ C$	-1.2	-1.8	-2.4	V
Static Drain-Source On-Resistance	$R_{DS(on)}$	$V_{GS}=-10V, I_D=-35A, T_j=25^\circ C$	-	10	13	$m\Omega$
		$V_{GS}=-4.5V, I_D=-20A, T_j=25^\circ C$	-	14.5	22	$m\Omega$
Diode Forward Voltage	V_{SD}	$I_S=-35A, V_{GS}=0V, T_j=25^\circ C$	-	-0.86	-1.2	V
Gate Resistance	R_G	$f=1MHz, T_j=25^\circ C$	-	7	-	Ω
Dynamic Parameters						
Input Capacitance	C_{iss}	$V_{DS}=-30V, V_{GS}=0V, f=1MHz, T_j=25^\circ C$	-	5029	-	pF
Output Capacitance	C_{oss}		-	327	-	
Reverse Transfer Capacitance	C_{rss}		-	299	-	
Switching Parameters						
Total Gate Charge	Q_g	$V_{GS}=-10V, V_{DS}=-30V, I_D=-35A, T_j=25^\circ C$	-	112	-	nC
Gate-Source Charge	Q_{gs}		-	16.6	-	
Gate-Drain Charge	Q_{gd}		-	26.7	-	
Reverse Recovery Charge	Q_{rr}	$I_F=-35A, di/dt=100A/\mu s, V_{GS}=0V, V_R=-30V, T_j=25^\circ C$	-	37.6	-	nC
Reverse Recovery Time	t_{rr}		-	28.4	-	ns
Turn-on Delay Time	$t_{D(on)}$	$V_{GS}=-10V, V_{DS}=-30V, I_D=-35A, R_{GEN}=3\Omega, T_j=25^\circ C$	-	12.6	-	ns
Turn-on Rise Time	t_r		-	36	-	
Turn-off Delay Time	$t_{D(off)}$		-	150	-	
Turn-off Fall Time	t_f		-	83	-	

Note:

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- The value of $R_{\theta JA}$ is measured with the device mounted on the 40mm*40mm*1.1mm single layer FR-4 PCB board with 1 in² pad of 2oz. Copper, in the still air environment with $T_A=25^\circ C$. The maximum allowed junction temperature of $175^\circ C$. The value in any given application depends on the user's specific board design.
- Thermal resistance from junction to soldering point (on the exposed drain pad).

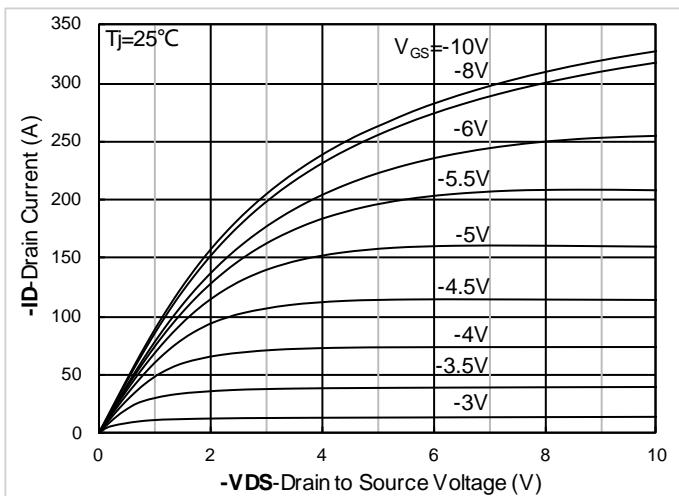
**■Typical Electrical and Thermal Characteristics Diagrams**

Figure 1. Output Characteristics; typical values

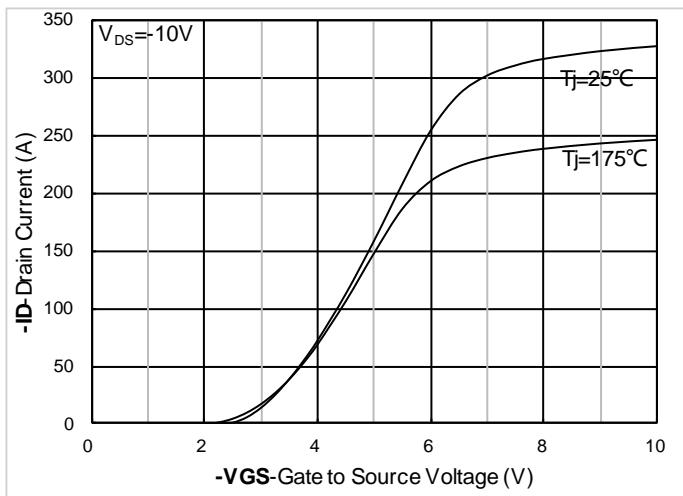


Figure 2. Transfer Characteristics; typical values

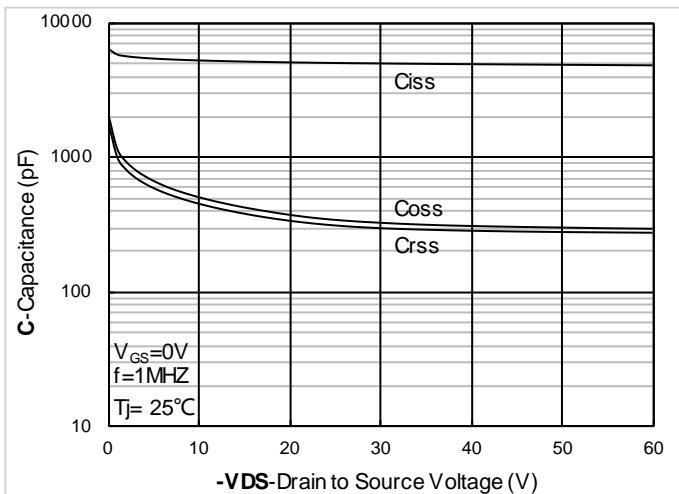


Figure 3. Capacitance Characteristics; typical values

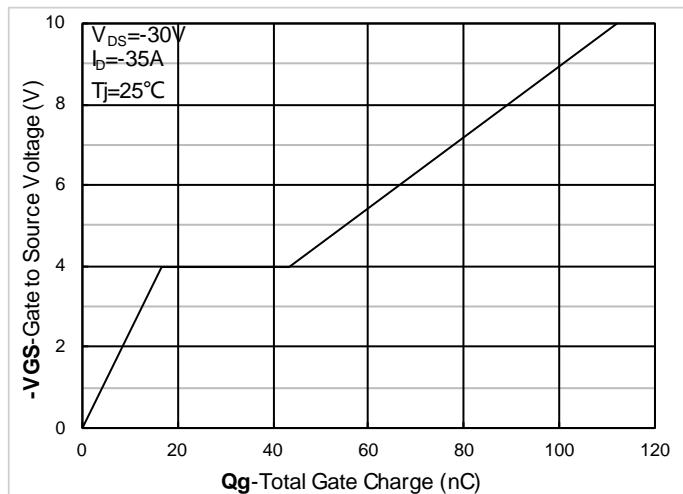


Figure 4. Gate Charge; typical values

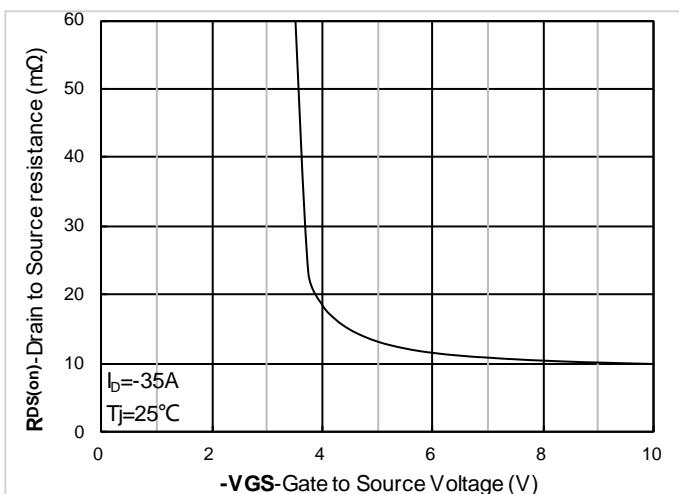


Figure 5. On-Resistance vs. Gate to Source Voltage; typical values

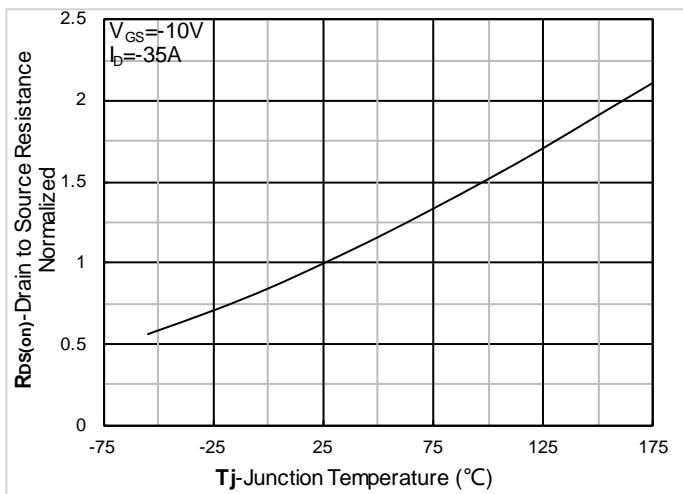


Figure 6. Normalized On-Resistance

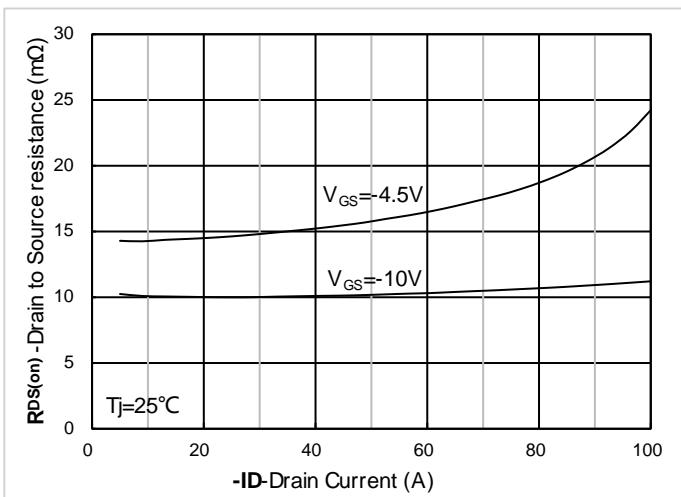


Figure 7. RDS(on) vs. Drain Current; typical values

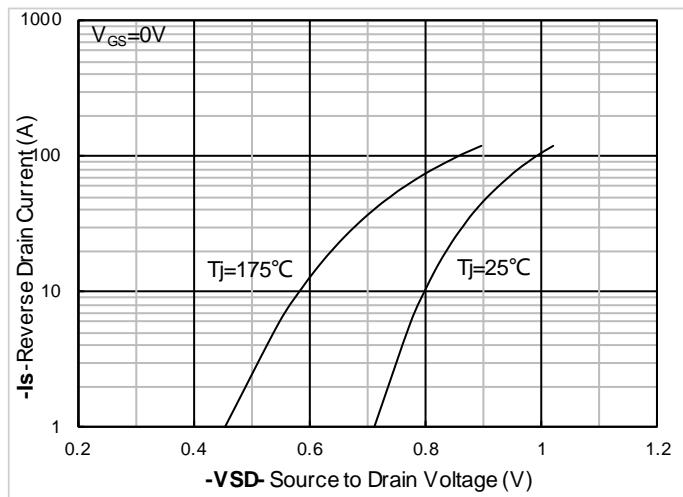


Figure 8. Forward characteristics of reverse diode; typical values

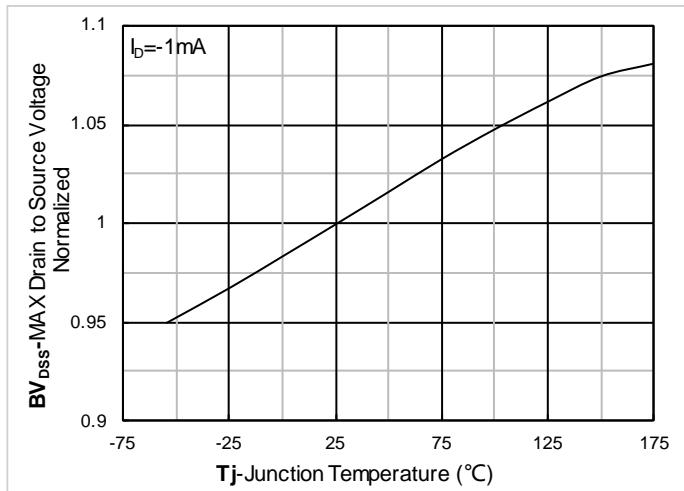


Figure 9. Normalized breakdown voltage

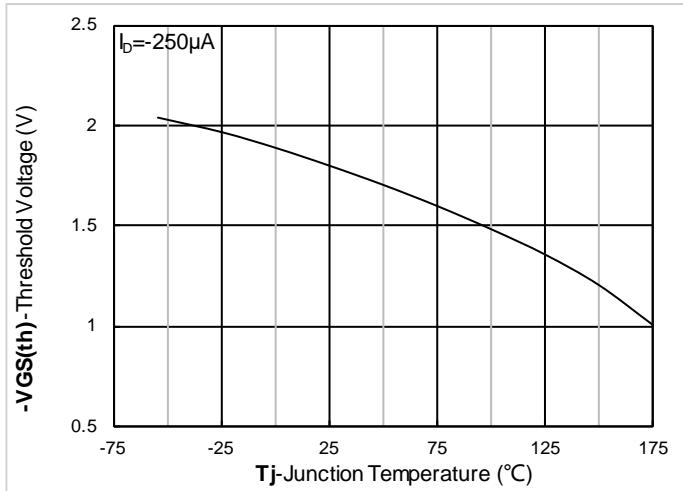


Figure 10. Gate Threshold voltage; typical values

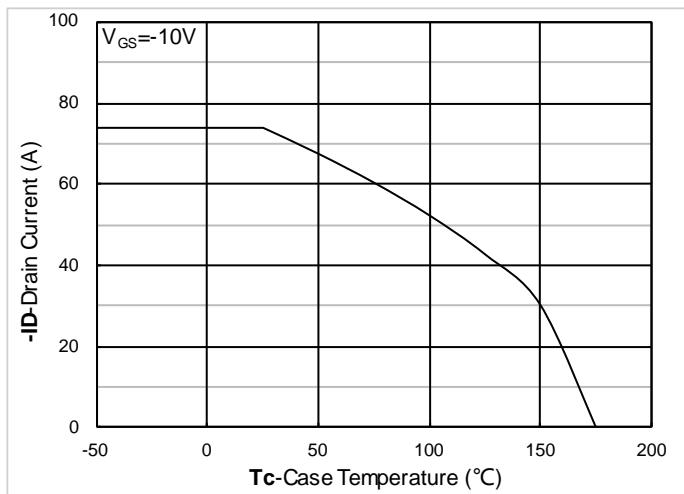


Figure 11. Current dissipation

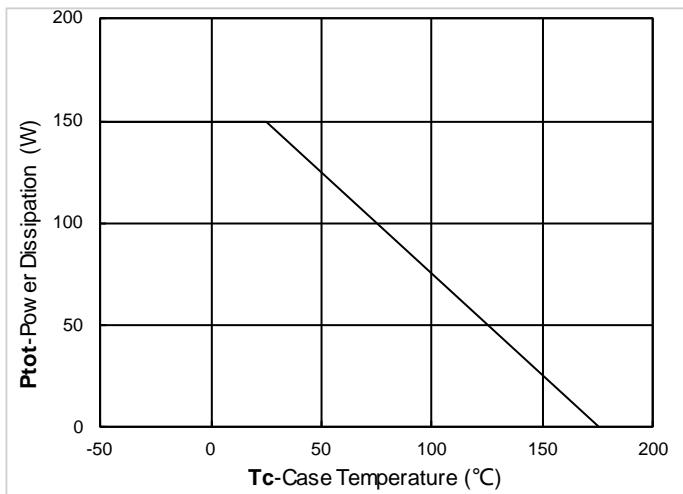


Figure 12. Power dissipation

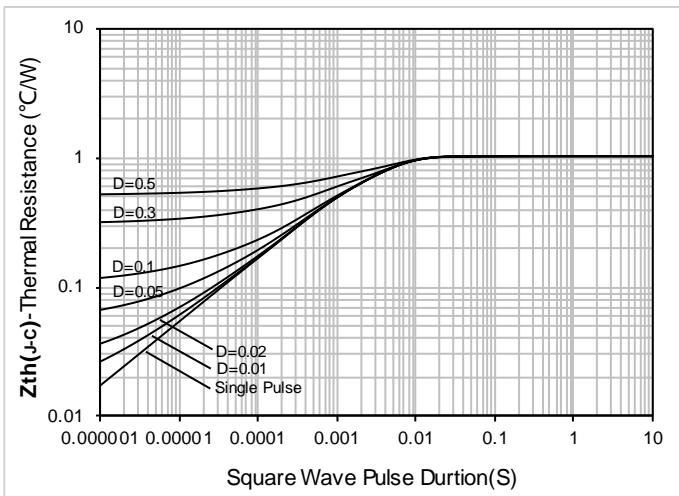


Figure 13. Maximum Transient Thermal Impedance

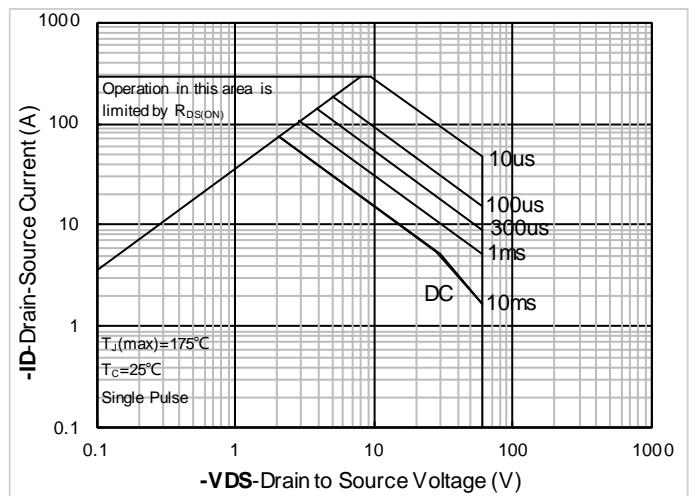
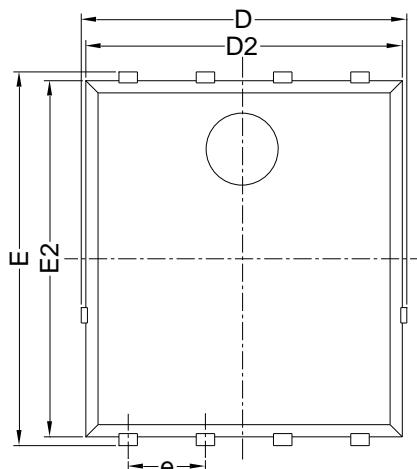
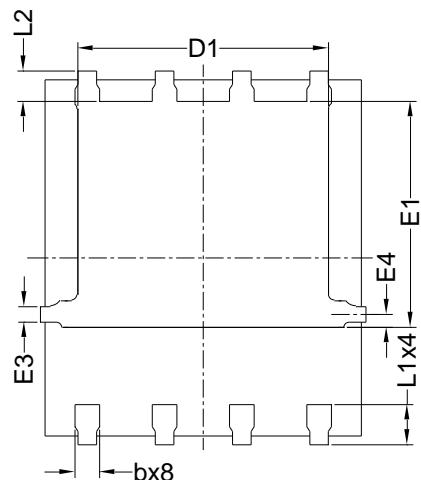
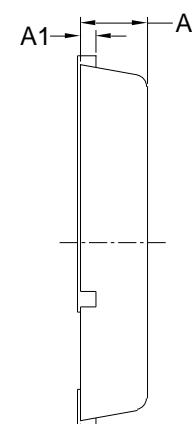
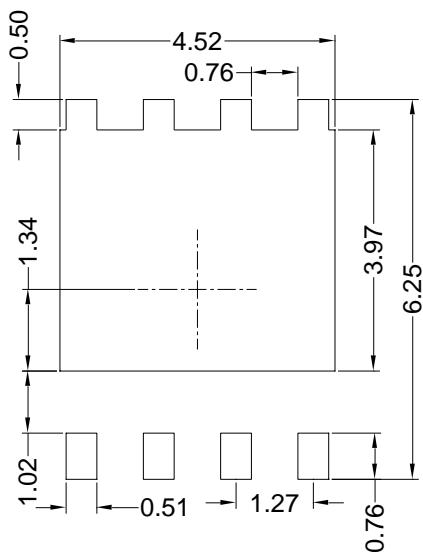


Figure 14. Safe Operation Area



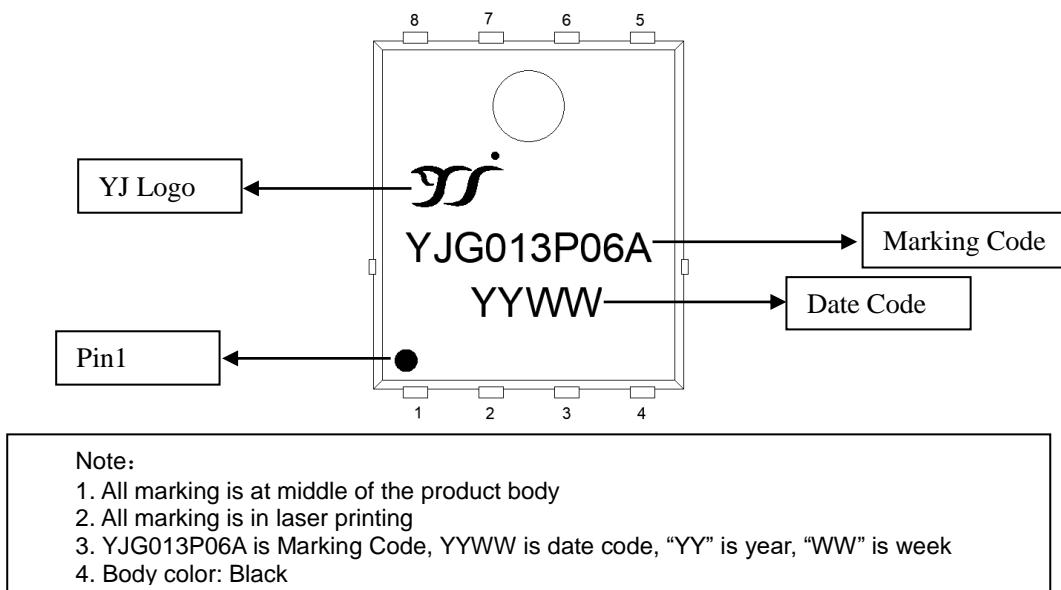
■ PDFN5060-8L-B-1.1MM Package information

Top View
正面视图Bottom View
背面视图Side View
侧面视图Suggested Solder Pad Layout
Top View

SYMBOL	MILLIMETER		
	MIN	NOM	MAX
D	5.15	5.35	5.55
E	5.95	6.15	6.35
A	1.00	1.10	1.20
A1	0.254 BSC		
A2			0.10
D1	3.92	4.12	4.32
E3	3.52	3.72	3.92
D2	5.00	5.20	5.40
E2	5.66	5.86	6.06
E4	0.254 REF		
L1	0.56	0.66	0.76
L2	0.50 BSC		
b	0.31	0.41	0.51
e	1.27 BSC		

Note:

1. Controlling dimension:in millimeters.
2. General tolerance: $\pm 0.10\text{mm}$.
3. The pad layout is for reference purposes only.

**■ Marking Information**



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